

Notice of References Cited

Application/Control No.

10/715,045

Applicant(s)/Patent Under
Reexamination
SENDYK ET AL.

Examiner

YUWEN PAN

Art Unit

2618

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,319,659	01-2008	Tsuie, Yih-Ming	370/203
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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